

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/591,206	IKEDA, MASAYUKI	
Examiner		Art Unit		Page 1 of 3
Hai V. Nguyen		2618		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,844,525 A	12-1998	Hayes et al.	343/702
*	B	US-6,075,500 A	06-2000	Kurz et al.	343/895
*	C	US-6,218,991 B1	04-2001	Sanad, Mohamed	343/700MS
*	D	US-6,239,749 B1	05-2001	Tzuang et al.	343/700MS
*	E	US-6,259,407 B1	07-2001	Tran, Allen	343/700MS
*	F	US-6,271,796 B1	08-2001	Itoh et al.	343/702
*	G	US-6,424,820 B1	07-2002	Burdick et al.	455/41.1
*	H	US-6,466,176 B1	10-2002	Maoz et al.	343/767
*	I	US-2002/0175872 A1	11-2002	Apostolos, John T.	343/749
*	J	US-2002/0183013 A1	12-2002	Auckland et al.	455/73
*	K	US-2002/0180648 A1	12-2002	Boyle et al.	343/702
*	L	US-6,535,170 B2	03-2003	Sawamura et al.	343/702
*	M	US-2003/0142019 A1	07-2003	Hilgers, Achim	343/700.0MS

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/591,206	IKEDA, MASAYUKI	
Examiner		Art Unit		Page 2 of 3
Hai V. Nguyen		2618		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,683,575 B2	01-2004	Sekine et al.	343/702
*	B	US-6,765,536 B2	07-2004	Phillips et al.	343/702
*	C	US-2004/0145529 A1	07-2004	Iguchi et al.	343/702
*	D	US-6,822,611 B1	11-2004	Kontogeorgakis et al.	343/702
*	E	US-6,845,253 B1	01-2005	Schantz, Hans Gregory	455/575.7
*	F	US-6,895,255 B1	05-2005	Bridgelall, Raj	455/552.1
*	G	US-6,911,944 B2	06-2005	Sekine et al.	343/702
*	H	US-6,963,310 B2	11-2005	Horita et al.	343/702
*	I	US-7,009,567 B2	03-2006	Iwai et al.	343/702
*	J	US-7,034,750 B2	04-2006	Asakura et al.	343/700MS
*	K	US-7,023,389 B2	04-2006	Demicco et al.	343/702
*	L	US-2006/0097927 A1	05-2006	Satoh et al.	343/702
*	M	US-7,102,578 B2	09-2006	Minemura, Takashi	343/702

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No. 10/591,206	Applicant(s)/Patent Under Reexamination IKEDA, MASAYUKI	
		Examiner Hai V. Nguyen	Art Unit 2618	Page 3 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0232492 A1	10-2006	Sawatani, Takuma	343/893
*	B	US-7,164,386 B2	01-2007	Baliarda et al.	343/700MS
*	C	US-7,245,950 B2	07-2007	Iwai et al.	455/575.7
*	D	US-2007/0225053 A1	09-2007	Iwai et al.	455/575.7
*	E	US-7,283,853 B2	10-2007	Kanazawa et al.	455/575.1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.